

**Notice of References Cited**

Application/Control No.

10/562,652

Applicant(s)/Patent Under

Reexamination

OSHIYAMA ET AL.

Examiner

Dawn Garrett

Art Unit

1774

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2004/0214041	10-2004	Lu et al.	428/690
*	C	US-2003/0091860	05-2003	Oshiyama et al.	428/690
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	N	EP 1353388 A2	10-2003	EP	Oshiyama et al.	---
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	S					
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**NON-PATENT DOCUMENTS**

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